

# **Development of Blue Laser Direct-Write Lithography System**

Hao-Wen Chang<sup>1</sup>, Hau-Wei Lee<sup>2,\*</sup>, Chorng-Tyan Lin<sup>3</sup>, Zhi-Qun Wen<sup>3</sup>

<sup>1</sup> Graduate Institute of Electro-Optical and Materials Science, National Formosa University.

<sup>2</sup> Department of Software and Advanced Technology Research, Chiuan-Yan Tech. Co., Ltd., Changhua County, 522, Taiwan.

<sup>3</sup> Metal Industries Research and Development Centre, Kaohsiung City

Received 20 October 2011; received in revised form 18 November 2011; accepted 16 December 2011

## **Abstract**

The optical lithography system researched in this study adopted the laser direct-write lithography technology with nano-positioning stage by using retailing blue ray optical pickup head contained 405nm wavelength and 0.85 numerical aperture of focus lens as the system lighting source. The system employed a photodiode received the focusing error signal reflected by the glass substrate to identify specimen position and automatic focused control with voice coil motor. The pattern substrate was loaded on a nano-positioning stage; input pattern path automatically and collocate with inner program at the same time. This research has successfully developed a blue laser lithography process system. The single spot size can be narrowed down to 3.07  $\mu\text{m}$  and the linewidth is 3.3 $\mu\text{m}$ , time of laser control can reach to 450 ns and the exposure pattern can be controlled by program as well.

**Keywords:** lithography, laser direct-write, blue ray, optical pickup head, voice coil motor

## **References**

- [1] O. Nalamasu, M. Cheng, A. G. Timko, V. Pol, E. Reichmanis, and L. F. Thompson, "An Overview of Resist Processing for Deep-UV Lithography," *Journal of Photopolymer Science and Technology*, vol. 4, pp. 299-318, 1991.
- [2] C. Vieu, F. Carcenac, A. Pepin, Y. Chen, M. Mejias, A. Lebib, L. Manin-Ferlazzo, L. Couraud, H. Launois, "Electron beam lithography: resolution limits and applications," *Applied Surface Science*, vol. 164, pp. 111-117, 2000.
- [3] T. R. Groves, D. Pickard, B. Rafferty, N. Crosland, D. Adam, G. Schubert, "Maskless electron beam lithography: prospects, progress, and challenges," *Microelectronic Engineering*, vol. 61-62, pp. 285-293, 2002.
- [4] A. Heuberger, "X-ray Lithography," *Journal of Vacuum Science & Technology B*, vol. 6, pp. 107-121, 1988.
- [5] S. Y. Chou, P. R. Krauss, P. J. Renstrom, "Imprint Lithography with 25-Nanometer Resolution," *Science*, vol. 272, pp. 85-87, 1995.
- [6] P. R. Krauss, S. Y. Chou, "Fabrication of Planar Quantum Magnetic Disk Structure using Electron," *Journal of Vacuum Science & Technology B*, vol. 13, pp. 2850-2857, 1995.
- [7] S. Y. Chou, P. R. Krauss, P. J. Renstrom, "Imprint of sub-25 nm vias and trenches in polymers," *Applied physics letters*, vol. 67, pp. 3114-3116, 1995.
- [8] S. Y. Chou, P. R. Krauss, and P. J. Renstrom, "Nanoimprint Lithography," *Journal of Vacuum Science & Technology B*, vol. 14, No. 6, pp. 4129-4132, 1996.
- [9] T. Bailey, B. J. Choi, M. Colburn, M. Meissl, S. Shaya, J. G. Ekerdt, S. V. Sreenivasan, C. G. Willson, "Step and flash imprint lithography template surface treatment and defect analysis," *Journal of Vacuum Science & Technology B*, vol. 18, pp. 3572-3577, 2000.
- [10] S. Y. Hwang, S. H. Hong, H. Y. Jung, H. Lee, 2005, "Fabrication of roll imprint stamp for continuous UV roll imprinting process," *Microelectronic Engineering*, vol. 78, pp. 359-363.

\* Corresponding author. E-mail address: orsino@aandf.com.tw

Tel.: +886-4-8711037; Fax: +886-4-8711053

- [11] C. P. Liu, Y. X. Huang, C. C. Hsu, T. R. Jeng, J. P. Chen, "Nanoscale Fabrication Using Thermal Lithography Technique," *IEEE Transaction on Magnetics*, vol. 45, pp. 2206-2208, 2009.
- [12] C. P. Liu, C. C. Hsu, T. R. Jeng, J. P. Chen, "Enhancing nanoscale patterning on Ge-Sb-Sn-O inorganic resist film by introducing oxygen during blue laser-induced thermal lithography," *Journal of Alloys and Compounds*, vol. 488, pp. 190-194, 2009.

